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INFORMATION DISCLOSURE				Application Number		10/080,958				
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STATEMENT BY APPLICANT					First Named Inventor. Albert Fazio		Albert Fazio	, , , , , C V C V		
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Signature	V. Naugen	3/1/03	

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard S.3). ⁴For Japanese patent documents, the indication of the year of reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁴Applicant is to place a check mark here if English language Translation is attached.

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•				First Named Inventor: Albert Fazio	10/08	0,958	3	
				Filing Date: 2/2//0	Z AU	10/080, 958 AU 2827		
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